

Precision, Bipolar Configuration for the **AD5546/AD5556** DAC

CIRCUIT FUNCTION AND BENEFITS

The circuit shown in Figure 1 provides precision, bipolar data conversion using the **AD5546/AD5556** current output digital-to-analog converter (DAC) with the **ADR01** 10 V precision reference and **AD8512** operational amplifier (op amp).

This circuit provides accurate, low noise, high speed output voltage capability and is well suited for process control, automatic test equipment (ATE), and digital calibration applications.

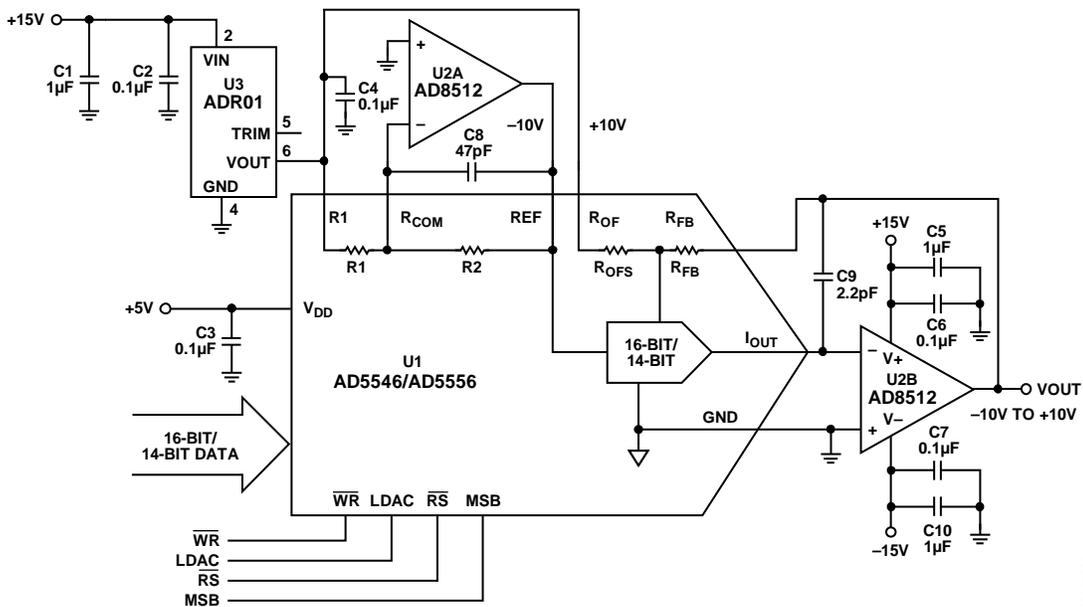


Figure 1. Bipolar Four-Quadrant Multiplying Mode with ± 10 V Output (Simplified Schematic)

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REVISION HISTORY

11/2017—Rev. B to Rev. C

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Changes to Figure 1 1

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Changes to Circuit Description Section 1
Changes to Figure 1 1

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CIRCUIT DESCRIPTION

The [AD5546/AD5556](#) are 16-bit/14-bit, precision, multiplying, low power, current output, parallel input DACs. They operate from a single 2.7 V to 5.5 V supply with ± 15 V multiplying references for four-quadrant outputs. Built in four-quadrant resistors facilitate the resistance matching and temperature tracking that minimize the number of components needed for multi-quadrant applications.

This circuit uses the [ADR01](#), which is a high accuracy, high stability, 10 V precision voltage reference. Because voltage reference temperature coefficient and long-term drift are primary considerations for applications requiring high precision conversion, this device is an ideal candidate.

An op amp is used in the current to voltage (I to V) stage of this circuit. The bias current and offset voltage of an op amp are both important selection criteria for use with precision current output DACs. Therefore, this circuit employs the [AD8512](#) op amp, which has ultralow offset voltage (100 μ V typical) and bias current (21 pA typical). C9 is a compensation capacitor. The value of C9 for this application is 2.2 pF, which is optimized to compensate for the external output capacitance of the DAC. The capacitor C8 acts as an integrator to reduce noise and a typical value of 47 pF is recommended.

The input offset voltage of the op amp is multiplied by the variable noise gain (due to the code dependent output resistance of the DAC) of the circuit. A change in this noise gain between two adjacent digital codes produces a step change in the output voltage due to the input offset voltage of the amplifier. This output voltage change is superimposed on the desired change in output between the two codes and gives rise to a differential linearity error, which, if large enough, can cause the DAC to be nonmonotonic. In general, the input offset voltage must be a fraction of an LSB to ensure monotonic behavior when stepping through codes. For the [ADR01](#) and the [AD5546](#), the LSB size is

$$\frac{10 \text{ V}}{2^{16}} = 153 \mu\text{V} \quad (1)$$

The input offset voltage of the [AD8512](#) is 100 μ V typical, thereby giving adequate margin.

The input bias current of an op amp also generates an offset at the voltage output as a result of the bias current flowing through the feedback resistor, RFB. In the case of the [AD8628](#), the input bias current is only 21 pA typical, which when flowing through the RFB resistor (10 k Ω typical) produces an error of only 0.21 μ V.

The [AD5546/AD5556](#) DAC architecture uses a current steering rail-to-rail ladder design that requires an external reference and op amp to convert the bipolar signal to an output voltage. V_{OUT} can be calculated for the [AD5546](#) using the following equation:

$$V_{OUT} = \left[\frac{V_{REF} \times D}{2^{16-1}} \right] - V_{REF} \quad (2)$$

where $D = 0$ to 65535 for 16-bit DAC (D is the decimal equivalent of the input code).

V_{OUT} can be calculated for the [AD5556](#) using the equation

$$V_{OUT} = \left[\frac{V_{REF} \times D}{2^{14-1}} \right] - V_{REF} \quad (3)$$

where $D = 0$ to 16383 for 14-bit DAC (D is the decimal equivalent of the input code).

COMMON VARIATIONS

The [AD8605](#) is another excellent op amp candidate for the current to voltage conversion circuit. It also has a low offset voltage and low bias current. The [ADR02](#) and [ADR03](#) are other low noise references available from the same reference family as the [ADR01](#). Other suitable low noise references are the [ADR441](#) and [ADR445](#) devices. The size of the reference input voltage is restricted by the rail-to-rail voltage of the op amp selected.

These circuits can also be used as a variable gain element by utilizing the multiplying bandwidth nature of the rail-to-rail structure of the [AD5546/AD5556](#) DAC. In this configuration, remove the external precision reference and apply the signal to be multiplied to the reference input pins of the DAC.

REFERENCES

[ADIsimPower Design Tool](#).

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